

**Notice of References Cited**

Application/Control No.

10/667,132

Applicant(s)/Patent Under  
Reexamination  
CHEN ET AL.

Examiner

Yemane M. Gerezgiher

Art Unit

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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2002/0143996 A1	10-2002	Odryna et al.	709/246
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
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**FOREIGN PATENT DOCUMENTS**

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